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20-bit FET Bus Switch



ADE-205-646A (Z)

Preliminary Rev. 1 Feb. 2002

Description

The HD74CBT16210 provides 20-bits of high speed TTL-compatible bus switching. The low on state resistance of the switch allows connections to be made with minimal propagation delay. The device is organized as a dual 10-bit bus switch with separate output enable (\overline{OE}) inputs. It can be used as two 10-bit bus switches or as one 20-bit bus switch. When \overline{OE} is low, the associated 10-bit bus switch is on, and port A is connected to port B. When \overline{OE} is high, the switch is open, and the high impedance state exists between the ports.

Features

- Minimal propagation delay through the switch.
- 5 Ω switch connection between two ports.
- TTL-compatible input levels.
- Ultra low quiescent power.
 - -Ideally suited for notebook applications.
- Package type

Product code example: HD74CBT16210TEL

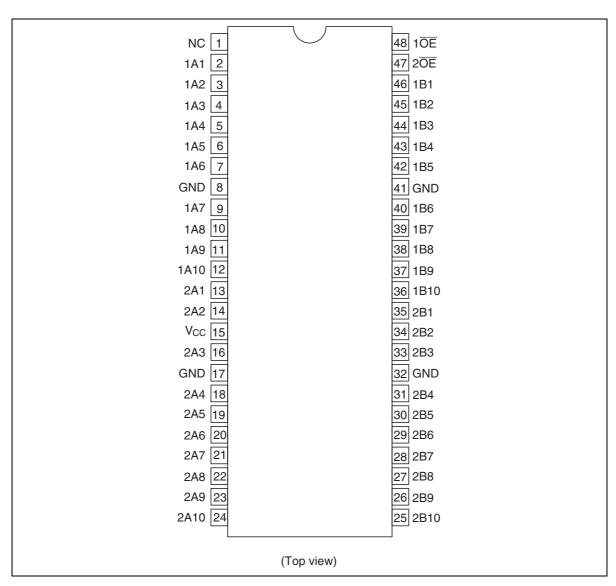
Package type	Package code	Package suffix	Taping code	
TSSOP-48pin	TTP-48DBV	Т	EL(1,000pcs / Reel)	

Function Table

Input OE	Function
L	A port = B port
Н	Disconnect

H: High levelL: Low level

Pin Arrangement



Absolute Maximum Ratings

Item	Symbol	Ratings	Unit	Conditions
Supply voltage range	V _{cc}	-0.5 to 7.0	V	
Input voltage range 1	V _i	-0.5 to 7.0	V	
Input clamp current	I _{IK}	-50	mA	V ₁ < 0
Continuous output current	I _o	128	mA	$V_o = 0$ to V_{cc}
Continuous current through V_{cc} or GND	I _{CC} or I _{GND}	±100	mA	
Maximum power dissipation at Ta = 25°C (in still air) ^{'2}	$P_{\scriptscriptstyle T}$	1.08	W	
Storage temperature	Tstg	-65 to 150	°C	

Notes:

The absolute maximum ratings are values which must not individually be exceeded, and furthermore, no two of which may be realized at the same time.

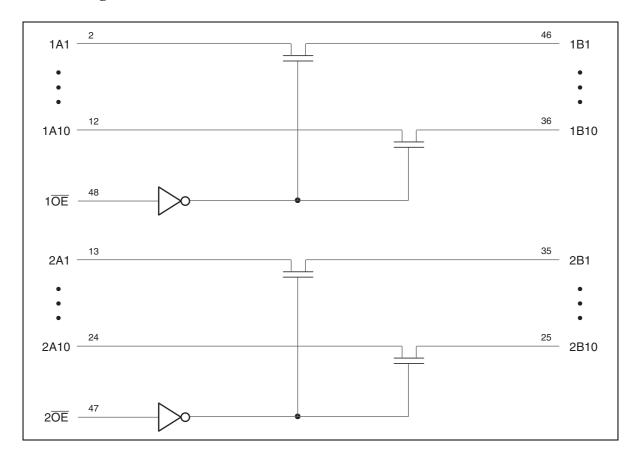
- 1. The input and output voltage ratings may be exceeded even if the input and output clamp-current ratings are observed.
- 2. The maximum package power dissipation was calculated using a junction temperature of 150° C.

Recommended Operating Conditions

Item	Symbol	Min	Max	Unit	Conditions
Supply voltage range	V _{cc}	4.0	5.5	V	
Input voltage range	V _I	0	5.5	V	
Output voltage range	V _{I/O}	0	5.5	V	
Input transition rise or fall rate	Δt / Δν	0	5	ns / V	$V_{cc} = 4.5 \text{ to } 5.5 \text{ V}$
Operating free-air temperature	Та	-40	85	°C	

Note: Unused or floating inputs must be held high or low.

Block Diagram



DC Electrical Characteristics

 $(Ta = -40 \text{ to } 85^{\circ}C)$

Item	Symbol	$V_{cc}(V)$	Min	Typ [™]	Max	Unit	Test conditions	
Clamp diode voltage	V _{IK}	4.5	_	_	-1.2	V	$I_{IN} = -18 \text{ mA}$	
Input voltage	V _{IH}	4.0 to 5.5	2.0	_		V		
	V _{IL}	4.0 to 5.5	_	_	0.8			
On-state switch resistance *2	R _{on}	4.0	_	14	20	Ω	$V_{IN} = 2.4 \text{ V},$ $I_{IN} = 15 \text{ mA}$ Typ at $V_{CC} = 4.0 \text{ V}$	
		4.5	_	5	7		$V_{IN} = 0 \text{ V},$ $I_{IN} = 64 \text{ mA}$	
		4.5	_	5	7		$V_{IN} = 0 \text{ V},$ $I_{IN} = 30 \text{ mA}$	
		4.5	_	8	12		$V_{IN} = 2.4 \text{ V},$ $I_{IN} = 15 \text{ mA}$	
Input current	I _{IN}	0 to 5.5	_	_	±1.0	μΑ	V _{IN} = 5.5 V or GND	
Off-state leakage current	l _{oz}	5.5	_	_	±1.0	μΑ	$0 \le A, B \le V_{cc}$	
Quiescent supply current	I _{cc}	5.5	_	_	3	μΑ	$V_{IN} = V_{CC}$ or GND, $I_{O} = 0$ mA	
Increase in I _{cc} per input '3	ΔI_{cc}	5.5	_	_	2.5	mA	One input at 3.4 V, other inputs at V _{cc} or GND	

Notes: For condition shown as Min or Max use the appropriate values under recommended operating conditions.

- 1. All typical values are at V_{cc} = 5 V (unless otherwise noted), Ta = 25°C.
- 2. Measured by the voltage drop between the A and B terminals at the indicated current through the switch. On-state resistance is determined by the lower voltage of the two (A or B) terminals.
- 3. This is the increase in supply current for each input that is at the specified TTL voltage level rather than $V_{\rm cc}$ or GND.

Capacitance

 $(Ta = 25^{\circ}C)$

Item	Symbol	V_{cc} (V)	Min	Тур	Max	Unit	Test conditions
Control input capacitance	C_{iN}	5.0	_	5	_	pF	$V_{IN} = 0 \text{ or } 3 \text{ V}$
Input / output capacitance	C _{I/O (OFF)}	5.0	_	7	_	pF	$\frac{V_o}{OE} = 0 \text{ or } 3 \text{ V}$

Note: This parameter is determined by device characterization is not production tested.

Switching Characteristics

 $(Ta = -40 \text{ to } 85^{\circ}C)$

• $V_{cc} = 4.0 \text{ V}$

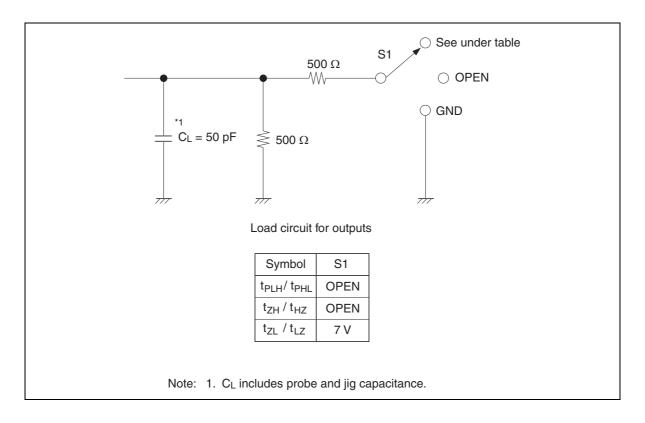
Item	Symbol	Min	Max	Unit	Test conditions	FROM (Input)	TO (Output)
Propagation delay time ¹	t _{PLH} t _{PHL}	_	0.35	ns	$C_L = 50 \text{ pF}$ $R_L = 500 \Omega$	A or B	B or A
Enable time	t _{zh} t _{zL}	_	9.3	ns	$C_L = 50 \text{ pF}$ $R_L = 500 \Omega$	ŌĒ	A or B
Disable time	t _{HZ} t _{LZ}		7.1	ns	$C_L = 50 \text{ pF}$ $R_L = 500 \Omega$	ŌĒ	A or B

• $V_{cc} = 5.0 \pm 0.5 \text{ V}$

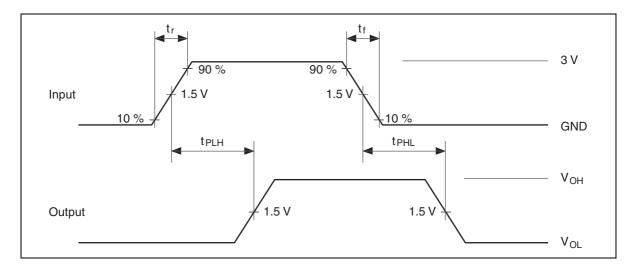
Item	Symbol	Min	Max	Unit	Test conditions	FROM (Input)	TO (Output)
Propagation delay time '1	t _{PLH} t _{PHL}	_	0.25	ns	$C_L = 50 \text{ pF}$ $R_L = 500 \Omega$	A or B	B or A
Enable time	t _{zh} t _{zL}	3.3	8.6	ns	$C_L = 50 \text{ pF}$ $R_L = 500 \Omega$	ŌĒ	A or B
Disable time	t _{HZ} t _{LZ}	2.8	7.9	ns	$C_L = 50 \text{ pF}$ $R_L = 500 \Omega$	ŌĒ	A or B

Note: 1. The propagation delay is the calculated RC time constant of the typical on-state resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).

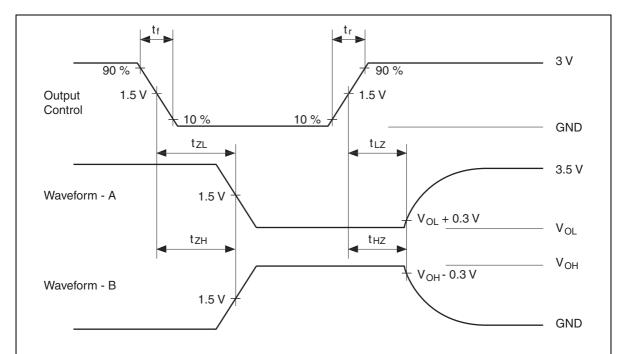
Test Circuit



Waveforms - 1



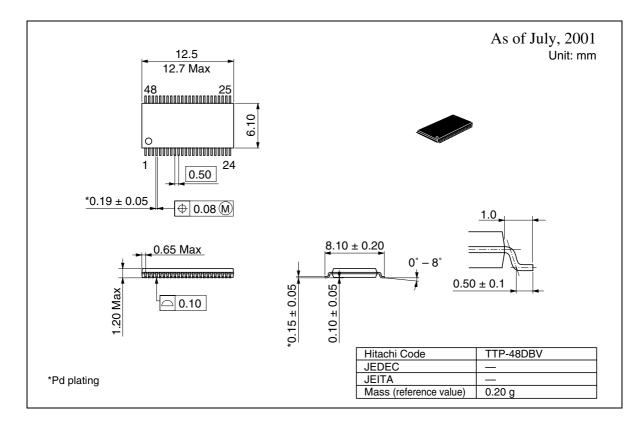
Waveforms - 2



Notes: 1. All input pulses are supplied by generators having the following characteristics : PRR \leq 10 MHz, $Z_O = 50~\Omega$, $t_r \leq$ 2.5 ns, $t_f \leq$ 2.5 ns.

- 2. Waveform A is for an output with internal conditions such that the output is low except when disabled by the output control.
- 3. Waveform B is for an output with internal conditions such that the output is high except when disabled by the output control.
- 4. The output are measured one at a time with one transition per measurement.

Package Dimensions



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